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PATENT NUMBER and  
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM 10042032	FILING DATE 10/25/2001	CLASS 356	SUBCLASS E34.1	GAU 2877	EXAMINER T. NGUYEN
<b>**APPLICANTS:</b> Okahira Hiroyuki; Nakamura Yuzo; Morita Terumasa; Fujisaki Nobuo;					
<b>**CONTINUING DATA VERIFIED:</b> THIS APPLICATION IS A DIV OF 09/158,362 09/22/1998					
<b>** FOREIGN APPLICATIONS VERIFIED:</b> JAPAN 9-258552 09/24/1997 JAPAN 10-264342 09/18/1998					
PG-PUB <input type="checkbox"/> DO NOT PUBLISH <input type="checkbox"/>		RESCIND <input type="checkbox"/>			
Foreign priority claimed <input type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 conditions met <input type="checkbox"/> yes <input type="checkbox"/> no Verified and Acknowledged Examiners's initials				ATTORNEY DOCKET NO 980615CD/LH	
TITLE : Apparatus for inspecting a substrate					
U.S. DEPT. OF COMM./PAT. & TM-PTO-436L (Rev. 12-94)					

<b>NOTICE OF ALLOWANCE MAILED</b>		<b>CLAIMS ALLOWED</b>	
		Assistant Examiner	Total Claims Print Claim for O.G.
<b>ISSUE FEE</b>		<b>DRAWING</b>	
Amount Due	Date Paid	Primary Examiner	Sheets Drwg. Figs. Drwg. Print Fig.
<input type="checkbox"/> <b>TERMINAL DISCLAIMER</b>		PREPARED FOR ISSUE	Application Examiner
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